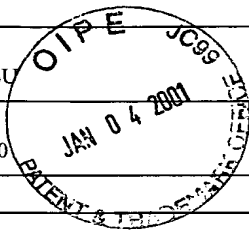


Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 105192.01		APPLICATION NO. 09/722,506	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Koji SHIGEMATSU		GROUP 2851	
				FILING DATE November 28, 2000			



U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
HN		5,835,285	01-98	Matsuzawa et al.	359	754
HN		5,903,400	05-99	Endo	359	758
HN		5,943,172	08-99	Sasaya et al.	359	754
HN		5,956,182	09-99	Takahashi	359	649
HN		6,008,884	12-99	Yamaguchi et al.	355	53
HN		6,084,723	07-00	Matsuzawa et al.	359	754
HN		6,088,171	07-00	Kudo	359	754
HN		6,104,544	08-00	Matsuzawa et al.	359	649

FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
HN		EP-A1-0 828 172	03-98	Europe		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)		

EXAMINER	Nguyen, Hung Henry	DATE CONSIDERED	4/17/02
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Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 105192.01		APPLICATION NO. Rule 53(b) Divisional of 09/234,969 filed January 21, 1999	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Koji SHIGEMATSU			
				FILING DATE November 28, 2000		GROUP 2851	


U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
HN		5,437,946	08-95	Mccoy	430	5
		4,948,238	08-90	Araki et al.	350	469
		5,856,883	01-99	Sander	358	389
		5,831,776	11-98	Sasaya et al.	359	754
		5,808,814	09-98	Kudo	359	754
		5,781,278	07-98	Matsuzawa et al.	355	53
		5,623,365	04-97	Kuba	359	569
		5,617,182	04-97	Wakamoto et al.	355	53
		5,555,479	09-96	Nakagiri	359	355
		5,477,304	12-95	Nishi	355	53
		5,437,946	08-95	Mccoy.	430	5
		4,948,238	08-90	Araki et al.	350	469
		5,930,049	07-99	Suenaga et al.	359	650
		5,920,379	07-99	Matsuyama	355	67
	HN		5,990,926	11-99	Mercado	347

FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
HN		JP-7-140385	06-95	Japan		
		EP-A2-732 605	09-96	Europe		
		JP-7-128592	05-95	Japan		
HN		JP-5-034593	01-93	Japan		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)	

EXAMINER <div style="font-size: 1.2em; font-family: cursive;">Nguyen, Hung Henry</div>	DATE CONSIDERED <div style="font-size: 1.2em; font-family: cursive;">4/17/02</div>
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				FILING DATE November 28, 2000		GROUP 2851	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
HN		5,781,278	07-98	Matsuzawa et al.	355	53	
		5,717,518	02-98	Shafer et al.	359	357	
		5,636,000	06-97	Ushida et al.	355	30	
		5,473,410	12-95	Nishi	355	53	
		5,392,094	02-95	Kudo			
		5,307,207	04-94	Ichihara			
		5,260,832	11-93	Togino et al.			
		5,237,367	08-93	Kudo			
		5,172,275	12-92	DeJager	349	75J	
		5,170,207	12-92	Tezuka et al.	355	53	
		5,105,075	04-92	Ohta	250	201.2	
		4,939,630	07-90	Kikuchi et al.	362	268	
HN		4,931,830	06-90	Suwa et al.	355	71	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
HN		EP-A2-803 755	10-97	Europe	/	/	
		EP-A2-770 895	05-97	Europe	/	/	
		EP-A2-733 605	09-96	Europe	/	/	
		EP-A2-721 150	07-96	Europe	/	/	
HN		EP-A1-717 299	06-96	Europe	/	/	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
HN		"Quality of Microlithographic Projection Lenses" by J. Braat, SPIE Proceedings, vol. 811, Optical Microlithographic Technology for Integrated Circuit Fabrication and Inspection, H. Stover, S. Wittekoek, Eds., pp. 22-30 (April 1987)					
EXAMINER				DATE CONSIDERED			
Nguyen, Hung Henry				4/17/02			
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